

PATENT NUMBER OR
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10008549	11/13/2001	936	56	1743	SNAY

**APPLICANTS: Mabile Michel; Mathis Gerard; Jplu Etienne; Pouyat Dominique; Dumont Christophe;

**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A DIV OF 09/353,668 07/15/1999 PAT 6,352,672 *

WHICH IS A CON OF 08/651,330 05/22/1996 ABN

WHICH IS A DIV OF 08/094,085 07/28/1993 PAT 5,527,684 *

WHICH IS A 371 OF PCT/FR92/00069 01/27/1992

(*)Data provided by applicant is not consistent with PTO records.

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** FOREIGN APPLICATIONS VERIFIED:

FRANCE PCT FR 92/0069 01/27/1992

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed	<input type="checkbox"/> yes <input type="checkbox"/> no		ATTORNEY DOCKET NO
35 USC 119 conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no		CIS-0010
Verified and Acknowledged Examiners's initials			

TITLE : Method of measuring the luminescence emitted in a luminescent assay

U.S. DEPT. OF COMM./PAT. & TM-PTO-436L(Rev. 12-94)

